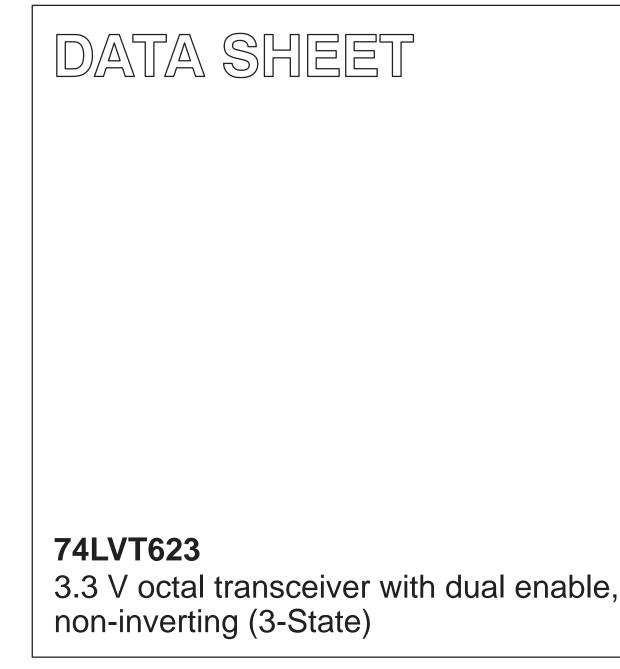
INTEGRATED CIRCUITS



Product specification Supersedes data of 1999 Jul 09 File under Integrated Circuits, IC24 Handbook 2001 Mar 12





74LVT623

FEATURES

- Separate controls for data flow in each direction
- Output capability: +64 mA/–32 mA
- TTL input and output switching levels
- Input and output interface capability to systems at 5 V supply
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- Live insertion/extraction permitted
- No bus current loading when output is tied to 5 V bus
- Power-up 3-State
- Power-up reset
- Latch-up protection exceeds 500 mA per JEDEC Std 17
- ESD protection exceeds 2000 V per MIL STD 883 Method 3015 and 200 V per Machine Model

QUICK REFERENCE DATA

DESCRIPTION

The 74LVT623 is a high-performance BiCMOS product designed for V_{CC} operation at 3.3 V.

The 74LVT623 device is an octal transceiver featuring non-inverting 3-State bus compatible outputs in both send and receive directions. The 74LVT623 is designed for asynchronous two-way communication between data buses. The control function implementation allows for maximum flexibility in timing. This device allows data transmission from the A bus to the B bus or from the B bus to the A bus, depending upon the logic levels at the Enable inputs (OEBA and OEAB). The Enable inputs can be used to disable the device so that the buses are effectively isolated.

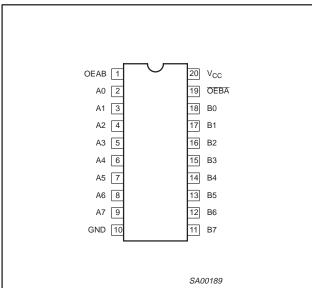
Control of data flow from B to A is similar, but using the $\overline{\text{EBA}},$ $\overline{\text{LEBA}},$ and $\overline{\text{OEBA}}$ inputs.

	SYMBOL	PARAMETER	CONDITIONS T _{amb} = 25 °C; GND = 0 V	TYPICAL	UNIT
	t _{PLH} t _{PHL}	Propagation delay An to Bn or Bn to An	C _L = 50 pF; V _{CC} = 3.3 V	2.3 2.5	ns
	C _{IN}	Input capacitance	V _I = 0 V or 3.0 V	4	pF
Γ	C _{I/O}	I/O capacitance	Outputs disabled; $V_{I/O} = 0 V \text{ or } 3.0 V$	7	pF
	I _{CCZ}	Total supply current	Outputs disabled; $V_{CC} = 3.6 V$	0.13	mA

ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	TYPE NUMBER	DWG NUMBER
20-Pin Plastic SO	–40 °C to +85 °C	74LVT623D	SOT163-1
20-Pin Plastic SSOP Type II	–40 °C to +85 °C	74LVT623DB	SOT339-1
20-Pin Plastic TSSOP Type I	–40 °C to +85 °C	74LVT623PW	SOT360-1

PIN CONFIGURATION

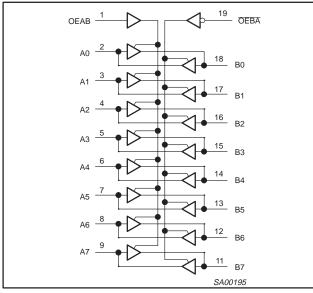


PIN DESCRIPTION

PIN NUMBER	SYMBOL	NAME AND FUNCTION
1	OEAB	Output enable input, A side to B side (active-High)
2, 3, 4, 5, 6, 7, 8, 9	A0 – A7	Data inputs/outputs (A side)
18, 17, 16, 15, 14, 13, 12, 11	B0 – B7	Data inputs/outputs (B side)
19	OEBA	Output enable input, B side to A side (active-Low)
10 GND		Ground (0 V)
20	V _{CC}	Positive supply voltage

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LOGIC SYMBOL



FUNCTION TABLE

INPUTS		INPUTS/C	OUTPUTS
OEBA	OEAB	An	Bn
L	L	An = Bn	Inputs
Н	Н	Inputs	Bn = An
Н	L	Z	Z
L	Н	An = Bn	Bn = An

H = High voltage level

L = Low voltage level

Z = High impedance "off" state

ABSOLUTE MAXIMUM RATINGS^{1, 2}

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		-0.5 to +4.6	V
I _{IK}	DC input diode current	V ₁ < 0	-50	mA
VI	DC input voltage ³		-0.5 to +7.0	V
I _{OK}	DC output diode current	V _O < 0	-50	mA
V _{OUT}	DC output voltage ³	Output in Off or High state	-0.5 to +7.0	V
	DC output ourroat	Output in Low state	128	
IOUT	DC output current	Output in High state	-64	mA
T _{stg}	Storage temperature range		-65 to +150	°C

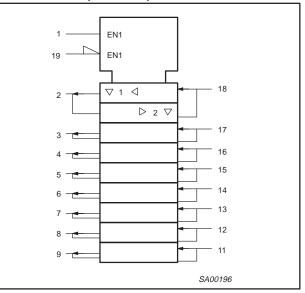
NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

 The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150 °C.

3. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

LOGIC SYMBOL (IEEE/IEC)



RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIM	UNIT	
STMBOL	FARAMETER	MIN	МАХ	
V _{CC}	DC supply voltage	2.7	3.6	V
VI	Input voltage	0	5.5	V
VIH	High-level input voltage	2.0		V
V _{IL}	Low-level input voltage		0.8	V
I _{OH}	High-level output current		-32	mA
	Low-level output current		32	mA
I _{OL}	Low-level output current; current duty cycle \leq 50%; f \geq 1 kHz		64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate; outputs enabled		10	ns/V
T _{amb}	Operating free-air temperature range	-40	+85	°C

DC ELECTRICAL CHARACTERISTICS

					LIMITS		
SYMBOL	PARAMETER TEST CONDITIONS			Temp = -40 °C		°C to +85 °C	
			MIN	TYP ¹	MAX	1	
V _{IK}	Input clamp voltage	$V_{CC} = 2.7 \text{ V}; \text{ I}_{IK} = -18 \text{ mA}$			-0.9	-1.2	V
		V_{CC} = 2.7 to 3.6 V; I_{OH} = -100 μ A V ₀		V _{CC} -0.2	V _{CC} -0.1		
V _{OH}	High-level output voltage	V _{CC} = 2.7 V; I _{OH} = -8 mA		2.4	2.5		V
		V _{CC} = 3.0 V; I _{OH} = -32 mA		2.0	2.2		1
		V _{CC} = 2.7 V; I _{OL} = 100 μA			0.1	0.2	
		V _{CC} = 2.7 V; I _{OL} = 24 mA			0.3	0.5	1
V _{OL}	Low-level output voltage	V _{CC} = 3.0 V; I _{OL} = 16 mA			0.25	0.4	V
		V _{CC} = 3.0 V; I _{OL} = 32 mA			0.3	0.5	
		V _{CC} = 3.0 V; I _{OL} = 64 mA			0.4	0.55	1
V _{RST}	Power-up output low voltage ⁵	V_{CC} = 3.6 V; I _O = 1 mA; V _I = GND or V _{CC}	:		0.13	0.55	V
	Input leakage current	V_{CC} = 3.6 V; V_{I} = V_{CC} or GND	Control pins		±0.1	±1	μΑ
		$V_{CC} = 0 \text{ or } 3.6 \text{ V}; \text{ V}_{I} = 5.5 \text{ V}$			1	10	
I _I		V _{CC} = 3.6 V; V _I = 5.5 V	I/O Data pins ⁴		1	20	
		$V_{CC} = 3.6 \text{ V}; \text{ V}_{I} = V_{CC}$			0.1	1	
		$V_{CC} = 3.6 \text{ V}; \text{ V}_{I} = 0$			-1	-5	
I _{OFF}	Output off current	$V_{CC} = 0$ V; V _I or V _O = 0 to 4.5 V	•		1	±100	μA
	Bus Hold current	V _{CC} = 3 V; V _I = 0.8 V		75	150		
HOLD	A or B ports	V _{CC} = 3 V; V _I = 2.0 V		-75	-150		μA
I_{EX}	Current into an output in the High state when $V_O > V_{CC}$	V _O = 5.5 V; V _{CC} = 3.0 V			60	125	μA
I _{PU/PD}	Power up/down 3-State output current ³	$V_{CC} \le 1.2 \text{ V}; V_O = 0.5 \text{ V} \text{ to } V_{CC}; V_I = \text{GND or } V_{CC}; OE/OE = \text{Don't care}$			15	±100	μA
I _{CCH}	V_{CC} = 3.6 V; Outputs High, V_{I} = GND or V_{CC} , I_{O} = 0			0.13	0.19		
I _{CCL}	Quiescent supply current	V_{CC} = 3.6 V; Outputs Low, V_I = GND or V_{CC} , I_O = 0			3	12	mA
I _{CCZ}		V_{CC} = 3.6 V; Outputs Disabled; V_I = GND or V_{CC} , I_O = 0			0.13	0.19	
ΔI_{CC}	Additional supply current per input pin ²	V_{CC} = 3 V to 3.6 V; One input at V _{CC} –0.6 Other inputs at V _{CC} or GND	3 V,		0.1	0.2	mA

NOTES:

1. All typical values are at $V_{CC} = 3.3$ V and $T_{amb} = 25$ °C. 2. This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND. 3. This parameter is valid for any V_{CC} between 0 V and 1.2 V with a transition time of up to 10 msec. From $V_{CC} = 1.2$ V to $V_{CC} = 3.3$ V ± 0.3 V a transition time of 100 μsec is permitted. This parameter is valid for T_{amb} = 25 °C only.

4. Unused pins at V_{CC} or GND. 5. For valid test results, data must not be loaded into the flip-flops (or latches) after applying the power.

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AC CHARACTERISTICS

GND = 0 V, $t_R = t_F$ = 2.5 ns, C_L = 50 pF, R_L = 500 Ω ; T_{amb} = -40 °C to +85 °C.

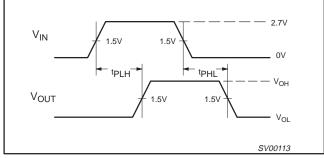
			LIMITS				
SYMBOL	PARAMETER	WAVEFORM	٧ _c	_C = 3.3 V ±0.	.3 V	V _{CC} = 2.7 V	UNIT
			MIN	TYP ¹	MAX	MAX	
t _{PLH} t _{PHL}	Propagation delay An to Bn, Bn to An	1	1.0 1.0	2.3 2.5	3.5 3.7	4.3 4.1	ns
t _{PZH}	Output enable time	2	1.0	3.7	5.9	7.6	ns
t _{PZL}	OEBA to An	3	1.1	3.7	5.9	6.8	
t _{PHZ}	Output disable time	2	1.8	3.6	5.0	5.5	ns
t _{PLZ}	OEBA to An	3	1.8	3.2	4.5	4.6	
t _{PZH}	Output enable time	2	1.0	4.2	6.3	7.8	ns
t _{PZL}	OEAB to Bn	3	1.4	4.3	6.2	6.9	
t _{PHZ}	Output disable time	2	2.3	3.9	6.1	6.9	ns
t _{PLZ}	OEAB to Bn	3	2.0	3.6	5.3	5.8	

NOTE:

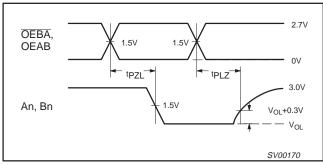
1. All typical values are at V_{CC} = 3.3 V and T_{amb} = 25°C.

AC WAVEFORMS

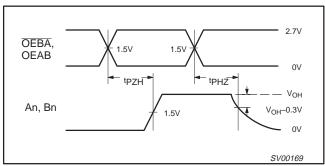
 V_{M} = 1.5 V, V_{IN} = GND to 2.7 V







Waveform 3. 3-State Output Enable Time to Low Level and Output Disable Time from Low Level

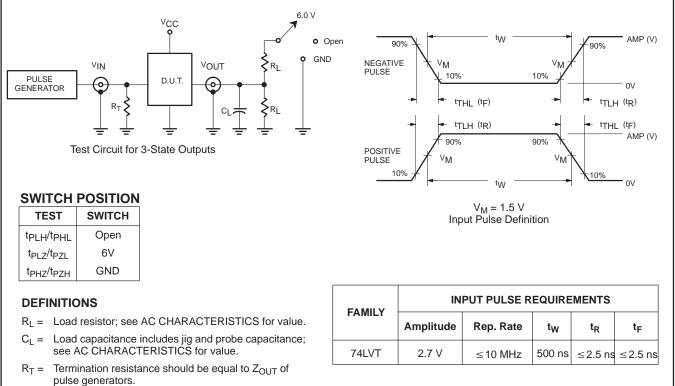


Waveform 2. 3-State Output Enable Time to High Level and Output Disable Time from High Level

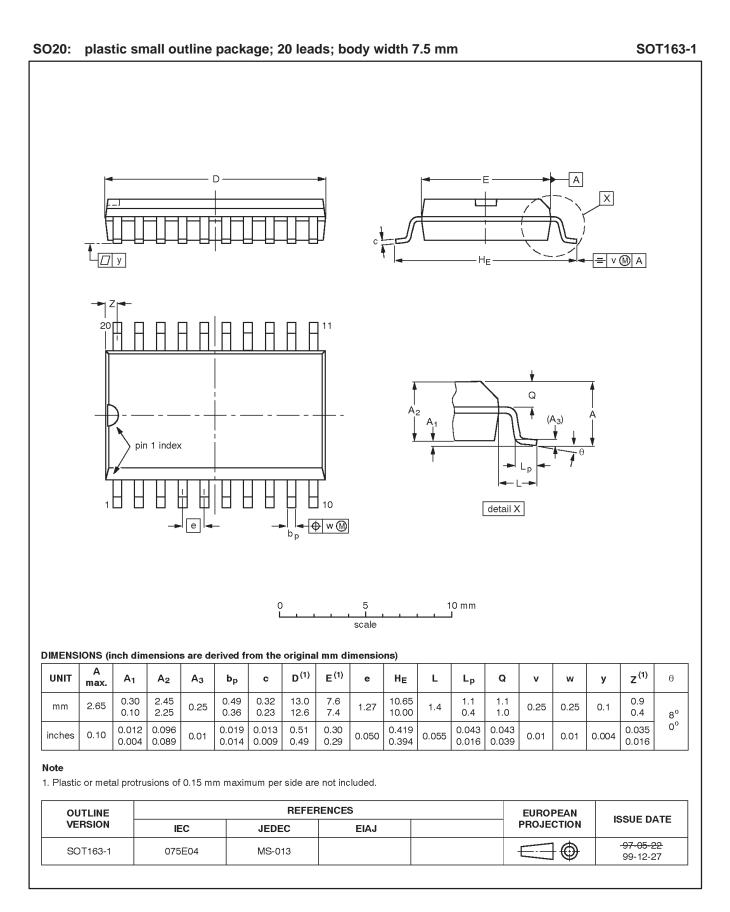
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Product data

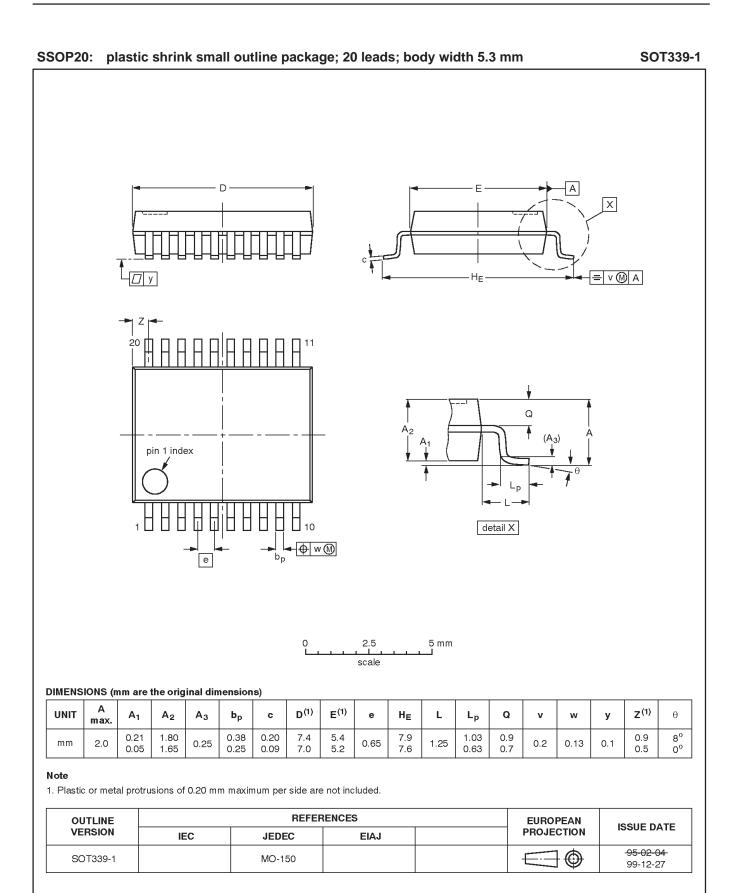
TEST CIRCUIT AND WAVEFORM



74LVT623

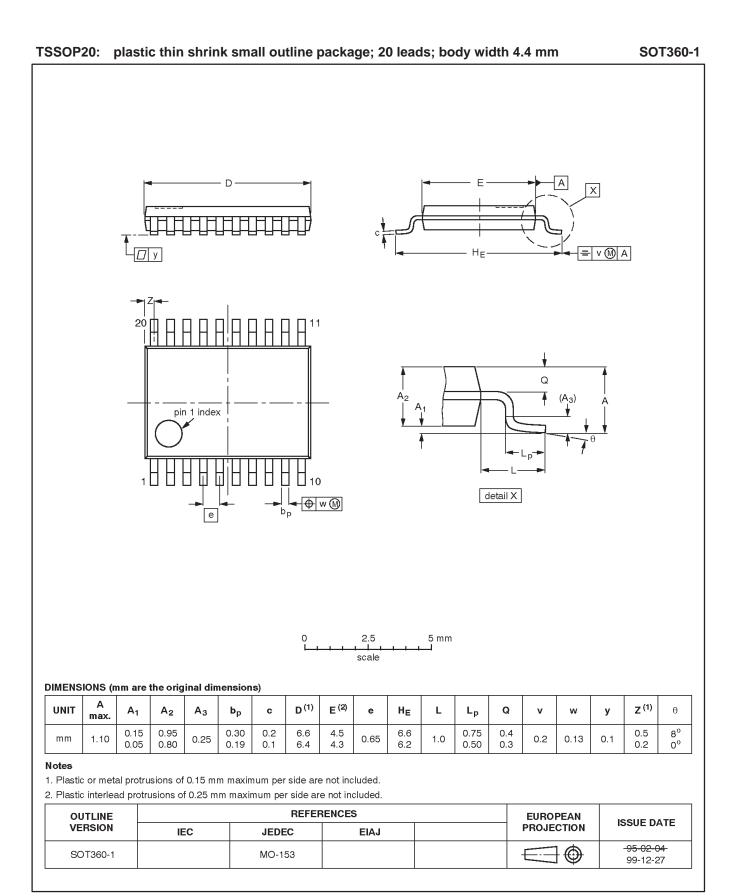


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Product data

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Data sheet status

Data sheet status ^[1]	Product status ^[2]	Definitions
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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